



# VeeMAX III with ATR – Variable Angle, Single Reflection ATR for Monolayers and Depth Profiling Studies



# FEATURES

- Continuously variable set angle 30 to 80 degrees
- 0.4 to 46 micron depth of penetration ideal for depth profiling studies
- High throughput for excellent quality spectra
- Optional, high-pressure clamp for sampling of films, coatings or powdered samples
- Integrated position for manual or automated polarizer
- Automated option with electronic control module and AutoPRO software for automated, high-precision experiments
- VeeMAX III can be used as a variable angle of incidence specular reflection accessory
- Configurable for specialized applications monolayer studies and spectroelectrochemistry
- Sealed and purgeable optical design to eliminate water vapor and carbon dioxide interferences





JASCO France 17 Rue des Cerisiers 91090 Lisses - France The VeeMAX III with ATR offers continuous variable angle of incidence and a variety of crystal plates to selectively control the depth of penetration of the IR beam into the sample. ATR applications include the study of layered samples, coatings, release agents, monolayers on silicon and chemical migration studies.

The VeeMAX III with ATR accessory provides exceptionally high throughput (over 50% with 45 degree ZnSe crystal) to minimize sampling time and enable detection of low concentration components in samples of complex composition. The crystal flat plates offered for the VeeMAX III are ideal for solid and layered samples and are designed for use with the optional pressure clamp. The combination of large crystal diameter (20 mm) and slip-clutch pressure clamp provides sample-to-crystal contact without altering layered sample composition. The optional liquids retainer may be added to the crystal plate for analysis of liquid samples.



Depth profiling study of layered polymer film. FTIR spectra collected using ZnSe crystal at set angles of incidence from 43 to 65 degrees. IR absorbance band at 1591 cm<sup>-1</sup> clearly increases relative to other bands as we probe deeper into the sample.

Monolayers and ultra-thin films absorbed on silicon or gold substrate are easily sampled using the VeeMAX III equipped with a high refractive index ATR crystal. Compared to specular reflectance sampling for monolayer analysis, an increase in sensitivity of up to 1–2 orders of magnitude may be realized via ATR sampling. For these applications, the VeeMAX III accessory is configured to include a high-angle Ge flat plate (60 or 65 degrees), the highpressure clamp with a 7.8-mm pressure tip, and a polarizer.



Analysis of monomolecular layer on silicon – VeeMAX III with 60 degree Ge crystal, pressure clamp with 7.8-mm tip and p polarization.

Tél. 01 64 97 09 60 Fax: 01 85 09 90 76 email: jascofrance@jascofrance.fr A spectroelectrochemical cell option for the VeeMAX III is also available. The innovative design offers a chemical-resistant vessel sealed to an ATR crystal using an O-ring. The assembly is mounted on the VeeMAX III. The crystals are interchangeable for optimizing spectral results and are removable to allow electrode coating on the ATR surface. The high throughput of the VeeMAX III with ATR provides excellent sensitivity and reduced sampling time. Alternatively, a flat IR transparent window or 60 degree CaF<sub>2</sub> prism may be installed to permit specular reflection sampling. The electrochemistry cell is equipped with a precision micrometer for electrode positioning, and is user-configurable.



VeeMAX III spectroelectrochemical cell – maximum flexibility with its interchangeable and removable crystals.

Temperature controlled crystal flat plates are available for thermal studies. The maximum temperature is 130 °C for all crystal types. PIKE Technologies' temperature controller allows unlimited ramps to be easily programmed using PIKE TempPRO software (sold separately). Data collection as a function of time or temperature may be prescribed for most FTIR spectrometers.



TempPRO software for graphical setup and control of kinetic measurements.



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Motorized control of angle of incidence via personal computer is available for the accessory. AutoPRO control software interfaces with most FTIR software packages for automated data collection. The Automated VeeMAX III is ideal for depth of profiling studies as it greatly speeds and improves the precision and reproducibility of the data collection process.





AutoPRO Software (left) configured for the Automated VeeMAX III (shown above with polarizer option) for automated depth profiling studies.

Angle of incidence and polarization angle can be set independently.

VEEMAX III WITH A	TR SPECIFICATIONS	
ATR Crystal Choice	ZnSe, Ge, Si, ZnS	
<b>Crystal Plate Mounting</b>	User-changeable plates	
<b>Crystal Plate Mounts</b>	Stainless Steel	
Crystal Dimension (surface)	20-mm diameter	
Optics	All reflective	
Pressure Device	Rotating, continuous variable pressure; click stop at maximum	
Heating Options Accuracy	130 °C +/- 0.5% of set point	
Sensor Type	3 wire Pt RTD (low drift, high stability)	
Temperature Control	Touch-panel display with USB interface.	
C € .@	PIKE TempPRO software (sold separately) for PC control with unlimited ramps and automated data collection.	
Input	100–240 VAC, auto setting, external power supply	
Output	24 VDC/50 W maximum	
Purge Sealing	Purge tubes and purge barb included	
Accessory Dimensions (W x D x H)	177 x 92 x 162 mm (excludes clamp height and baseplate)	
Spectroelectrochemical Vessel Dimensions	25 mm dia tapering to 19 mm, 25 mm tall	
Spectroelectrochemical Vessel Volume	7.5 mL	
Spectroelectrochemical Vessel Material	Polytetrafluoroethylene or PEEK	
FTIR Compatibility	Most, specify model and type	

## Heated crystal plate

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# **ORDERING INFORMATION**

## VEEMAX III BASE OPTICS

<i>(must select)</i> Part Number	DESCRIPTION
013-11XX	VeeMAX III Variable Angle Specular Reflectance Accessory Includes specular reflectance masks (2, 5/8 and 3/8"), purge tubes, purge kit and spectrometer base mount.
013-12XX	Automated VeeMAX III Includes controller, cabling, sample masks (2", 5/8" and 3/8"), gold substrate alignment mirror, FTIR base mount, and purge tubes

Note: Replace XX with your spectrometer's Instrument Code listed on page 164.

## **CRYSTAL PLATES FOR VEEMAX III ATR**

(must select 1 or more for ATR)

PART NUMBER	DESCRIPTION
013-4021	Flat Plate, ZnSe, 45°
013-4031	Flat Plate, ZnSe, 60°
013-4041	Flat Plate, Ge, 45°
013-4051	Flat Plate, Ge, 60°
013-4061	Flat Plate, Ge, 65°
013-4081	Flat Plate, Si, 45°
013-4071	Flat Plate, Si, 60°
013-4091	Flat Plate, ZnS, 45°
013-4096	Flat Plate, ZnS, 60°
013-3401	Liquids Retainer for VeeMAX III ATR crystals
013-3501	VeeMAX III ATR Flow Cell

Notes: VeeMAX III Crystal Plates are pre-aligned and pinned-in-place. Changing crystal plates is easy and fast to optimize sampling results. ZnS crystal plate is excellent for deepest penetration of IR beam. If you need a crystal not listed here, please contact us. Flow cell and Liquids Retainer require High-Pressure Clamp. Reconditioning service for used VeeMAX crystal plates is available.

# **OPTIONAL CRYSTAL PLATES FOR HEATED VEEMAX III ATR**

PART NUMBER	DESCRIPTION
013-4121	Heated Flat Plate, ZnSe, 45°
013-4131	Heated Flat Plate, ZnSe, 60°
013-4141	Heated Flat Plate, Ge, 45°
013-4151	Heated Flat Plate, Ge, 60°
013-4161	Heated Flat Plate, Ge, 65°
013-4171	Heated Flat Plate, Si, 60°
013-4181	Heated Flat Plate, Si, 45°
013-4191	Heated Flat Plate, ZnS, 45°
013-4196	Heated Flat Plate, ZnS, 60°
076-1610	Digital Temperature Control Module
007-0207	PIKE TempPRO Software

Notes: Heated VeeMAX III crystal plates may be heated to 130 °C. Temperature control module selection is required for heated crystal plates. If PC control is desired, TempPRO software must be purchased (sold separately from Temperature Control Module).

#### PRESSURE CLAMP FOR VEEMAX III

(must select for solids, films or powder analysis)

PART NUMBER DESCRIPTION

013-3101	VeeMAX III ATR Pressure Clamp
025-3094	7.8-mm ATR Pressure Tip
	7.0-IIIIII ATK Plessure Tip

Notes: The pressure clamp is required for solids, films, coatings and powdered samples. The pressure clamp is supplied with 20-mm tip for solid samples. The 7.8-mm pressure tip is required for monolayers on silicon or small samples.



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#### **VEEMAX III SAMPLING OPTIONS**

PART NUMBER	DESCRIPTION
090-1000	Manual Polarizer, ZnSe
090-1200	Manual Polarizer, KRS-5
090-3000	Precision Manual Polarizer, ZnSe
090-3200	Precision Manual Polarizer, KRS-5
090-5000	Precision Automated Polarizer, ZnSe, USB
090-5100	Precision Automated Polarizer, KRS-5, USB
007-0300	PIKECalc Software

Notes: PIKECalc software provides easy calculations of depth of penetration, effective angle of incidence and critical angle for ATR measurements. Automated option includes PIKE Technologies AutoPRO software and controller. Other polarizer options are found in the polarization section of this catalog. Automated VeeMAX III and automated polarizer interface simultaneously.

#### SPECTROELECTROCHEMICAL CONFIGURATION

PART NUMBER	DESCRIPTION
013-3300	Electrochemical Cell, PTFE
013-3370	Electrochemical Cell, PEEK
013-3402	Heated Electrochemical Cell, PTFE
160-5546	ZnSe Crystal, 45°
160-5550	ZnSe Crystal, 60°
160-5547	Ge Crystal, 45°
160-5551	Ge Crystal, 60°
160-5548	Si Crystal, 45°
160-5552	Si Crystal, 60°
160-5549	ZnS Crystal, 45°
160-5553	ZnS Crystal, 60°
160-5527	CaF <sub>2</sub> Crystal, 60°
160-1144	CaF <sub>2</sub> Flat Window, 20-mm diameter
160-1304	ZnSe Flat Window, 20-mm diameter
013-3320	Flat Window Holder, Delrin™
013-3345	45° Crystal Holder, Delrin
013-3360	60° Crystal Holder, Delrin
013-3374	45° Crystal Holder, PEEK
013-3376	60° Crystal Holder, PEEK
013-3445	Heated 45° Crystal Holder
013-3460	Heated 60° Crystal Holder

Notes: The electrochemical configuration requires electrochemical cell, crystal or window holder and VeeMAX III accessory. Must select one or more crystal or flat window. Choose a crystal holder to match the crystal angle. A flat window or CaF<sub>2</sub> crystal are used for specular reflectance sampling. Other window types for specular reflectance measurements may be found in our listing of transmission windows, 20 mm x 2 mm. The heated electrochemical cell requires the selection of a Digital Temperature Control Module. If PC control is desired TempPRO software must be purchased (sold separately from Temperature Control Module). Electrodes supplied by the end-user.

## **REPLACEMENT PARTS**

PART NUMBER	DESCRIPTION
013-4010	Mask Set for VeeMAX
300-0002	Gold Substrate Alignment Mirror, 1.25 x 3.0"

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